

Notice of References Cited

Application/Control No.

10/726,677

Applicant(s)/Patent Under
Reexamination
CHOO ET AL.

Examiner

James A. Dudek

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP03-102323	04-1991	JP	Terushisa	349/189
*	O	2002-258299	01-2002	JP	Satoshi et al.	349/189
*	P	2002-014360	01-2002	JP	Norihiko et al.	349/189
*	Q	2002-341362	11-2002	JP	Mitsuru	349/189
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Patent Abstract of Japan, 2002-122870, 04-2002
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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